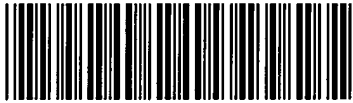


Search Notes

Application/Control No.

10/606,180

Examiner

Leon J. Harper

Applicant(s)/Patent under
Reexamination

KOJIMA ET AL.

Art Unit

2166

SEARCHED

Class	Subclass	Date	Examiner
707	3		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
QEM meeting	12/14/2005	LJH
consulted with Sam Rimell about prior art and scope	12/14/2005	LJH